

<b>Notice of References Cited</b>	Application/Control No. 09/994,774	Applicant(s)/Patent Under Reexamination HEINRICH ET AL.
	Examiner Katarzyna Wyrozebski Lee	Art Unit 1714

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,250,630	10-1993	Oshima et al.	525/301
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
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	J	US-			
	K	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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